

FEATURES

- Excellent Speed: 8 V/μs Typ**
- Low Noise: 11 nV/√Hz @ 1 kHz Max**
- Unity-Gain Stable**
- High Gain Bandwidth: 6.5 MHz Typ**
- Low Input Offset Voltage: 0.8 mV Max**
- Low Offset Voltage Drift: 4 μV/°C Max**
- High Gain: 500 V/mV Min**
- Outstanding CMR: 105 dB Min**
- Industry Standard Quad Pinouts**

GENERAL DESCRIPTION

The OP471 is a monolithic quad op amp featuring low noise, 11 nV/√Hz Max @ 1 kHz, excellent speed, 8 V/μs typical, a gain bandwidth of 6.5 MHz, and unity-gain stability.

The OP471 has an input offset voltage under 0.8 mV and an input offset voltage drift below 4 μV/°C, guaranteed over the full military temperature range. Open-loop gain of the OP471 is over 500,000 into a 10 kΩ load ensuring outstanding gain accuracy and linearity. The input bias current is under 25 nA limiting errors due to signal source resistance. The OP471's CMR of over 105 dB and PSRR of under 5.6 μV/V significantly reduce errors caused by ground noise and power supply fluctuations.

The OP471 offers excellent amplifier matching which is important for applications such as multiple gain blocks, low-noise instrumentation amplifiers, quad buffers and low-noise active filters.

The OP471 conforms to the industry standard 14-lead DIP pinout. It is pin-compatible with the LM148/LM149, HA4741, RM4156, MC33074, TL084 and TL074 quad op amps and can be used to upgrade systems using these devices.

For applications requiring even lower voltage noise the OP470 with a voltage density of 5 nV/√Hz Max @ 1 kHz is recommended.

PIN CONFIGURATIONS

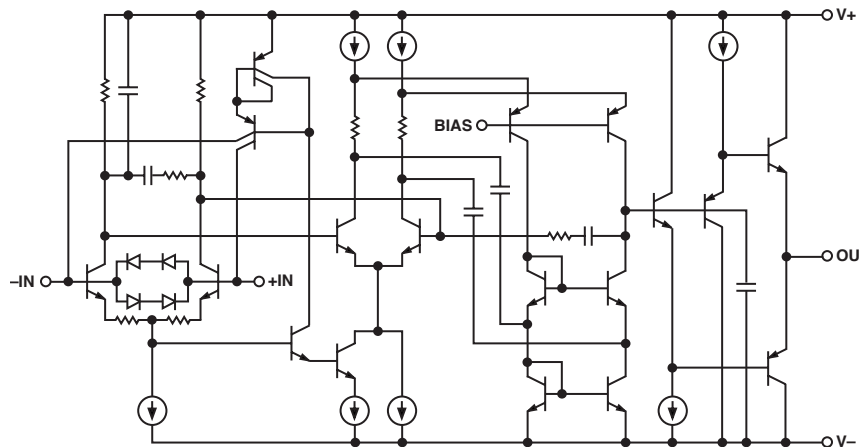
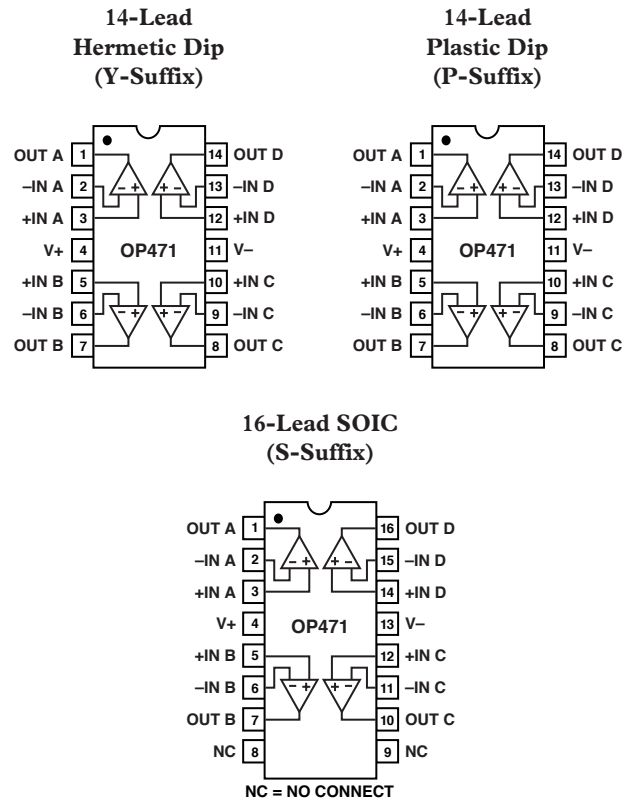


Figure 1. Simplified Schematic

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OP471—SPECIFICATIONS

ELECTRICAL CHARACTERISTICS (@ $V_S = \pm 15$ V, $T_A = 25^\circ\text{C}$, unless otherwise noted.)

Parameter	Symbol	Conditions	OP471E			OP471F			OP471G			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
Input Offset Voltage	V_{OS}		0.25	0.8		0.5	1.5		1.0	1.8	mV	
Input Offset Current	I_{OS}	$V_{CM} = 0$ V	4	10		7	20		12	30	nA	
Input Bias Current	I_B	$V_{CM} = 0$ V	7	25		15	50		25	60	nA	
Input Noise Voltage ¹	e_n p-p	0.1 Hz to 10 Hz	250	500		250	500		250	500	nV p-p	
Input Noise Voltage Density ²	e_n	$f_O = 10$ Hz	9	16		9	16		9	16	$\text{nV}/\sqrt{\text{Hz}}$	
		$f_O = 100$ Hz	7	12		7	12		7	12	$\text{nV}/\sqrt{\text{Hz}}$	
		$f_O = 1$ kHz	6.5	11		6.5	11		6.5	11	$\text{nV}/\sqrt{\text{Hz}}$	
Input Noise Current Density	i_n	$f_O = 10$ Hz	1.7			1.7			1.7		$\text{pA}/\sqrt{\text{Hz}}$	
		$f_O = 100$ Hz	0.7			0.7			0.7		$\text{pA}/\sqrt{\text{Hz}}$	
		$f_O = 1$ kHz	0.4			0.4			0.4		$\text{pA}/\sqrt{\text{Hz}}$	
Large-Signal Voltage Gain	A_{VO}	$V = \pm 10$ V	500	700		300	500		300	500	V/mV	
		$R_L = 10$ k Ω $R_L = 2$ k Ω	350	550		175	275		175	275	V/mV	
Input Voltage Range ³	IVR		± 11	± 12		± 11	± 12		± 11	± 12	V	
Output Voltage Swing	V_O	$R_L \geq 2$ k Ω	± 12	± 13		± 12	± 13		± 12	± 13	V	
Common-Mode Rejection	CMR	$V_{CM} = \pm 11$ V	105	120		95	115		95	115	dB	
Power Supply Rejection Ratio	PSRR	$V_S = 4.5$ V to 18 V	1	5.6		5.6	17.8		5.6	17.8	$\mu\text{V}/\text{V}$	
Slew Rate	SR		6.5	8		6.5	8		6.5	8	V/ μs	
Supply Current (All Amplifiers)	I_{SY}	No Load	9.2	11		9.2	11		9.2	11	mA	
Gain Bandwidth Product	GBW	$A_v = 10$	6.5			6.5			6.5		MHz	
Channel Separation ¹	CS	$V_O = 20$ V p-p $f_O = 10$ Hz	125	150		125	150		125	150	dB	
Input Capacitance	C_{IN}		2.6			2.6			2.6		pF	
Input Resistance Differential-Mode	R_{IN}		1.1			1.1			1.1		M Ω	
Input Resistance Common-Mode	R_{INCM}		11			11			11		G Ω	
Settling Time	t_S	$A_v = 1$	4.5			4.5			4.5		μs	
		To 0.1% To 0.01%	7.5			7.5			7.5		μs	

NOTES

¹Guaranteed but not 100% tested.

²Sample tested.

³Guaranteed by CMR test.

ELECTRICAL CHARACTERISTICS ($V_s = \pm 15\text{ V}$, $-25^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$ for OP471E/F, $-40^\circ\text{C} \leq T_A \leq 85^\circ$ for OP471G, unless otherwise noted.)

Parameter	Symbol	Conditions	OP471E			OP471F			OP471G			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
Input Offset Voltage	V_{OS}		0.3	1.1		0.6	2.0		1.2	2.5	mV	
Average Input Offset Voltage Drift	TCV_{OS}		1	4		2	7		4		$\mu\text{V}/^\circ\text{C}$	
Input Offset Current	I_{OS}	$V_{CM} = 0\text{ V}$	5	20		8	40		20	50	nA	
Input Bias Current	I_B	$V_{CM} = 0\text{ V}$	13	50		25	70		40	75	nA	
Large-Signal Voltage Gain	A_{VO}	$V_O = \pm 10\text{ V}$ $R_L = 10\text{ k}\Omega$ $R_L = 2\text{ k}\Omega$	375 250	600 400		200 125	400 200		200 125	400 200	V/mV	
Input Voltage Range*	IVR		± 11	± 12		± 11	± 12		± 11	± 12	V	
Output Voltage Swing	V_O	$R_L \geq 2\text{ k}\Omega$	± 12	± 13		± 12	± 13		± 12	± 13	V	
Common-Mode Rejection	CMR	$V_{CM} = \pm 11\text{ V}$	100	115		90	110		90	110	dB	
Power Supply Rejection Ratio	PSRR	$V_S = \pm 4.5\text{ V}$ to $\pm 18\text{ V}$	3.2	10		18	31.6		18	31.6	$\mu\text{V}/\text{V}$	
Supply Current (All Amplifiers)	I_{SY}	No Load	9.3	11		9.3	11		9.3	11	mA	

*Guaranteed by CMR test.

ABSOLUTE MAXIMUM RATINGS¹

Supply Voltage	$\pm 18\text{ V}$
Differential Input Voltage ²	$\pm 1.0\text{ V}$
Differential Input Current ²	$\pm 25\text{ mW}$
Input Voltage	Supply Voltage
Output Short-Circuit Duration	Continuous
Storage Temperature Range	
P, Y-Package	-65°C to $+150^\circ\text{C}$
Lead Temperature Range (Soldering, 60 sec)	300°C
Junction Temperature (T_j)	-65°C to $+150^\circ\text{C}$
Operating Temperature Range	
OP471E, OP471F	-25°C to $+85^\circ\text{C}$
OP471G	-40°C to $+85^\circ\text{C}$

NOTES

- ¹Absolute Maximum Ratings apply to packaged parts, unless otherwise noted.
- ²The OP471's inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise performance. If differential voltage exceeds $\pm 1.0\text{ V}$, the input current should be limited to $\pm 25\text{ mA}$.

Package Type	θ_{JA} *	θ_{JC}	Unit
14-Lead Hermetic DIP(Y)	94	10	$^\circ\text{C}/\text{W}$
14-Lead Plastic DIP(P)	76	33	$^\circ\text{C}/\text{W}$
16-Lead SOIC (S)	88	23	$^\circ\text{C}/\text{W}$

* θ_{JA} is specified for worst-case mounting conditions, i.e., θ_{JA} is specified for device in socket for TO, Cerdip, PDIP packages; θ_{JA} is specified for device soldered to printed circuit board for SO packages.

ORDERING GUIDE

$T_A = 25^\circ\text{C}$ $V_{OS\text{ MAX}}$ (μV)	Package Options		Operating Temperature Range
	14-Lead Cerdip	Plastic	
800	OP471EY		IND
1,500	OP471FY*		IND
1,800		OP471GP	XIND
1,800		OP471GS	XIND

*Not for new design. Obsolete April 2002.

For military processed devices, please refer to the standard microcircuit drawing (SMD) available at www.dscc.dla.mil/programs/milspec/default.asp
 5962-88565022A - OP471ARCMDA
 5962-88565023A - OP471ATCMDA
 5962-8856502CA - OP471AYMDA

CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the OP471 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

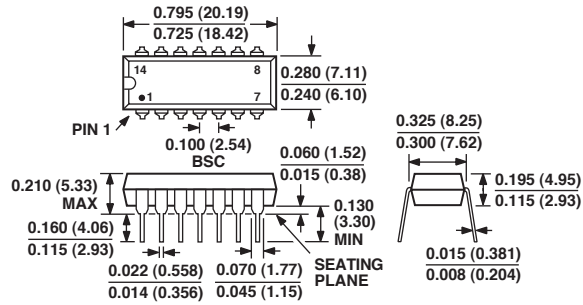


OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

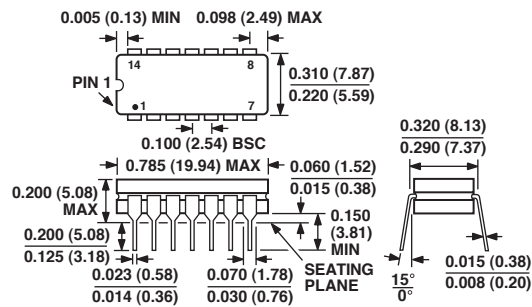
14-Lead PDIP Package

(N-14)



14-Lead CERDIP Package

(Q-14)



16-Lead SOIC Package

(R-16)

